









#### **[SN55HVD251,](http://www.ti.com/product/sn55hvd251?qgpn=sn55hvd251) [SN65HVD251](http://www.ti.com/product/sn65hvd251?qgpn=sn65hvd251)**

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## **SNx5HVD251 Industrial CAN Bus Transceiver**

- <span id="page-0-3"></span>
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- High Input Impedance Allows up to 120 Nodes on
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- <span id="page-0-5"></span>
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- <span id="page-0-2"></span>
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<span id="page-0-4"></span><span id="page-0-0"></span>

#### <span id="page-0-1"></span>**1 Features 3 Description**

Tools & **[Software](#page-29-0)** 

Drop-In Improved Replacement for the The HVD251 is intended for use in applications<br>PCA82C250 and PCA82C251 employing the Controller Area Network (CAN) serial employees the Controller • Bus-Fault Protection of ±36 V ISO 11898 Standard. The HVD251 provides differential transmit capability to the bus and Signaling Rates<sup>(1)</sup> up to 1 Mbps  $\qquad \qquad$  differential receive capability to a CAN controller at speeds up to 1 megabits per second (Mbps).

a Bus Designed for operation in harsh environments, the Bus Pin ESD Protection Exceeds 14 kV HBM device features cross-wire, overvoltage and loss of protection to  $\pm 36$  V. Also featured are protection to  $\pm 36$  V. Also featured are protection to  $\pm 36$  V. Also featured are overtemperature protection as well as  $-7-V$  to 12-V • Low-Current Standby Mode: 200-µA Typical common-mode range, and tolerance to transients of • Thermal Shutdown Protection ±200 V. The transceiver interfaces the single-ended CAN controller with the differential CAN bus found in • Glitch-Free Power-Up and Power-Down CAN Bus industrial, building automation, and automotive applications.<br>• DeviceNet Vendor ID #806

• DeviceNet Vendor ID #806 Rs, pin 8, selects one of three different modes of The signaling rate of a line is the number of voltage operation: high-speed, slope control, or low-power transitions that are made per second expressed in bps (bits mode. The bigh eneed mode of energrism is colected transitions that are made per second expressed in bps (bits mode. The high-speed mode of operation is selected by connecting pin 8 to ground, allowing the by connecting pin 8 to ground, allowing the transmitter output transistors to switch as fast as **<sup>2</sup> Applications** possible with no limitation on the rise and fall slope. • CAN Data Buses The rise and fall slope can be adjusted by connecting Industrial Automation **industrial Automation a** resistor to ground at pin 8; the slope is proportional to the pin's output current. Slope control with an • SAE J1939 Standard Data Bus Interface επιτείται του το το το μπο σαίρα cancin. Θύρε control with an<br>external resistor value of 10 kΩ gives about 15-V / μs<br>NMEA 2000 Standard Data Bus Interface serves about 2-V/us slew slew rate; 100 kΩ gives about 2-V/µs slew rate.

> If <sup>a</sup> high logic level is applied to the Rs pin 8, the **Block Diagram** device enters <sup>a</sup> low-current standby mode where the driver is switched off and the receiver remains active. The local protocol controller returns the device to the normal mode when it transmits to the bus.





(1) For all available packages, see the orderable addendum at the end of the data sheet.

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, **40** intellectual property matters and other important disclaimers. PRODUCTION DATA.

## **Table of Contents**



### <span id="page-1-0"></span>**4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

#### **Changes from Revision F (June 2015) to Revision G Page**

• Changed the value of HBM "All pins" From: ±14000 V To: ±6000 V. Changed the value of "CANH, CANL and GND" From: ±6000 V To: ±14000 V in the *ESD [Ratings](#page-3-3)* ... [4](#page-3-4)

#### **Changes from Revision E (March 2010) to Revision F Page**

- Added *Pin Configuration and Functions* section, *ESD Ratings* table, *Feature Description* section, *Device Functional Modes*, *Application and Implementation* section, *Power Supply Recommendations* section, *Layout* section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* section .............................. [1](#page-0-3)
- Changed the location of section "6.12 VREF-Pin Characteristics" to section 6.8 ... [6](#page-5-2)



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6.14 Typical Characteristics .. [9](#page-8-0) **13 Mechanical, Packaging, and Orderable 7 Parameter Measurement Information** ................ [11](#page-10-0) **Information** ... [30](#page-29-6)



**STRUMENTS** 

**EXAS** 

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#### **Changes from Revision B (September 2003) to Revision C Page**

• Changed the front page format... [1](#page-0-3) • Changed Junction temperature, T<sup>J</sup> - SOIC Package MAX value From 150°C To: 145°C ... [5](#page-4-10) • Changed the THERMAL CHARACTERISTICS table values ... [7](#page-6-0) • Changed the ABSOLUTE MAXIMUM POWER DISSIPATION RATINGS table values .. [8](#page-7-1)





**STRUMENTS** 

EXAS

### <span id="page-3-0"></span>**5 Pin Configuration and Functions**



#### **Pin Functions**



## <span id="page-3-1"></span>**6 Specifications**

### <span id="page-3-2"></span>**6.1 Absolute Maximum Ratings(1)(2)**

<span id="page-3-5"></span>

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *[Recommended](#page-4-0) Operating [Conditions](#page-4-0)* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential I/O bus voltages, are with respect to network ground pin.

### <span id="page-3-3"></span>**6.2 ESD Ratings**

<span id="page-3-4"></span>

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

#### <span id="page-4-0"></span>**6.3 Recommended Operating Conditions**



<span id="page-4-10"></span><span id="page-4-4"></span>(1) The algebraic convention, in which the least positive (most negative) limit is designated as minimum is used in this data sheet.

#### <span id="page-4-1"></span>**6.4 Thermal Information**



<span id="page-4-5"></span>(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953.](http://www.ti.com/lit/pdf/spra953)

#### <span id="page-4-2"></span>**6.5 Supply Current**

over operating free-air temperature range (unless otherwise noted)



(1) All typical values are at 25°C and with a 5-V supply.

#### <span id="page-4-3"></span>**6.6 Electrical Characteristics: Driver**

over recommended operating conditions (unless otherwise noted).

<span id="page-4-6"></span>

<span id="page-4-9"></span><span id="page-4-8"></span><span id="page-4-7"></span>(1) All typical values are at 25°C and with a 5-V supply.

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### **Electrical Characteristics: Driver (continued)**

over recommended operating conditions (unless otherwise noted).



#### <span id="page-5-0"></span>**6.7 Electrical Characteristics: Receiver**

over recommended operating conditions (unless otherwise noted).



### <span id="page-5-3"></span><span id="page-5-1"></span>**6.8 VREF-Pin Characteristics**

over recommended operating conditions (unless otherwise noted).

<span id="page-5-2"></span>

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#### <span id="page-6-0"></span>**6.9 Power Dissipation Characteristics**



## <span id="page-6-1"></span>**6.10 Switching Characteristics: Driver**

over recommended operating conditions (unless otherwise noted).



### <span id="page-6-3"></span><span id="page-6-2"></span>**6.11 Switching Characteristics: Device**

over recommended operating conditions (unless otherwise noted).



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#### **EXAS ISTRUMENTS**

#### <span id="page-7-0"></span>**6.12 Switching Characteristics: Receiver**

over recommended operating conditions (unless otherwise noted).



### <span id="page-7-1"></span>**6.13 Dissipation Ratings**



(1) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

(2) In accordance with the Low-K thermal metric definitions of EIA/JESD51-3.

(3) In accordance with the High-K thermal metric definitions of EIA/JESD51-7.



#### **6.14 Typical Characteristics**

<span id="page-8-5"></span><span id="page-8-4"></span><span id="page-8-3"></span><span id="page-8-2"></span><span id="page-8-1"></span><span id="page-8-0"></span>



#### **Typical Characteristics (continued)**

<span id="page-9-0"></span>



#### <span id="page-10-0"></span>**7 Parameter Measurement Information**





<span id="page-10-3"></span>



<span id="page-10-4"></span><span id="page-10-2"></span><span id="page-10-1"></span>

**Figure 12. Driver V<sub>OD</sub>** 





**Figure 13. Driver Test Circuit and Voltage Waveforms**

<span id="page-11-1"></span>

**Figure 14. Receiver Voltage and Current Definitions**



- A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 125 kHz, 50% duty cycle,  $t_r$  ≤ 6ns,  $t_f \leq 6$ ns,  $Z_O = 50$  Ω.
- <span id="page-11-0"></span>B.  $C_L$  includes instrumentation and fixture capacitance within  $\pm 20\%$ .

#### **Figure 15. Receiver Test Circuit and Voltage Waveforms**





<span id="page-12-1"></span>This test is conducted to test survivability only. Data stability at the R output is not specified.

#### **Figure 16. Test Circuit, Transient Overvoltage Test**



<span id="page-12-0"></span>



<span id="page-12-2"></span>



<span id="page-13-0"></span>The input pulse is supplied by a generator having the following characteristics: PRR ≤ 125 kHz, 50% duty cycle, t<sub>r</sub> ≤ 6ns,  $t_f \le 6$ ns,  $Z_O = 50$  Ω.

**Figure 18. Peak-to-Peak Common Mode Output Voltage**



<span id="page-13-1"></span>**Figure 19. TLOOP Test Circuit and Voltage Waveforms**





**Figure 20. Driver Short-Circuit Test**

<span id="page-14-0"></span>

- A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 125 kHz, 50% duty cycle,  $t_r$  ≤ 6ns,  $t_f \le 6$ ns,  $Z_O = 50 \Omega$ .
- <span id="page-14-1"></span>B. CL includes instrumentation and fixture capacitance within ±20%.

#### **Figure 21. Receiver Propagation Delay in Standby Test Circuit and Waveform**



<span id="page-15-1"></span>

- A. All input pulses are supplied by a generator having the following characteristics:  $f_{IN}$  < 1.5 MHz,  $T_A$  = 25°C, V<sub>CC</sub> = 5 V.
- <span id="page-15-0"></span>B. The receiver output should not change state during application of the common-mode input waveform.

**Figure 22. Common-Mode Input Voltage Rejection Test**



### <span id="page-16-0"></span>**8 Detailed Description**

#### <span id="page-16-1"></span>**8.1 Overview**

The SNx5HVD251CAN bus transceiver is compatible with the ISO 11898-2 High Speed CAN (Controller Area Network) physical layer standard. It is design to interface between the differential bus lines in controller area network and the CAN protocol controller at data rates up to 1 Mbps.

#### <span id="page-16-2"></span>**8.2 Functional Block Diagram**



#### <span id="page-16-3"></span>**8.3 Feature Description**



**Figure 23. Function Diagram (Positive Logic)**

#### **8.3.1 Mode Control**

R<sub>S</sub>, Pin 8, selects one of three possible modes of operation: high-speed, slope control, or low-power mode.

#### **8.3.2 High-Speed Mode**

The high-speed mode of operation can be selected by setting  $R_S$  (Pin 8) low. High-speed allows the output to switch as fast as possible with no internal limitations on the output rise and fall slopes. The CAN bus driver and receiver are fully operational and the CAN communication is bi-directional. The driver is translating a digital input on D to a differential output on CANH and CANL. The receiver is translating the differential signal from CANH and CANL to a digital output on R.

#### **8.3.3 Slope Control Mode**

The rise and fall slope of the SNx5HVD251 driver output can be adjusted by connecting a resistor from Rs (Pin 8) to ground (GND), or to a low-level input voltage as shown in [Figure](#page-17-0) 24. The slope of the driver output signal is proportional to the pin's output current. This slope control is implemented with an external resistor value of 10 kΩ to achieve a ~15-V/μs slew rate, and up to 100 kΩ to achieve a ~2.0-V/μs slew rate. [Figure](#page-9-0) 8 shows a plot of differential output transition time vs slope resistance from which the slew rate can be calculated.

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#### **Feature Description (continued)**

#### **8.3.4 Low-Power Mode**

If a high-level input (>0.75  $V_{CC}$ ) is applied to R<sub>S</sub> (Pin 8), the circuit enters a low-current, listen only standby mode during which the driver is switched off and the receiver remains active. If using this mode to save system power while waiting for bus traffic, the local controller can monitor the R output pin for a falling edge which indicates that a dominant signal was driven onto the CAN bus. The local controller can then drive the  $R_S$  pin low to return to slope control mode or high-speed mode.

#### **NOTE**

Silent mode may be used to implement babbling idiot protection, to ensure that the driver does not disrupt the network during a local fault. Silent mode may also be used in redundant systems to select or de-select the redundant transceiver (driver) when needed.



**Figure 24. Slope Control**

#### <span id="page-17-0"></span>**8.3.5 Thermal Shutdown**

The SNx5HVD251 has a thermal shutdown feature that turns off the driver outputs when the junction temperature nears 165°C. This shutdown prevents catastrophic failure from bus shorts, but does not protect the circuit from possible damage. The user should strive to maintain recommended operating conditions and not exceed absolute-maximum ratings at all times. If an SNx5HVD251 is subjected to many, or long-duration faults that can put the device into thermal shutdown, it should be replaced.



#### <span id="page-18-0"></span>**8.4 Device Functional Modes**

<span id="page-18-2"></span><span id="page-18-1"></span>

### **Table 2. Driver**

#### **Table 3. Receiver**



(1)  $H = high level; L = low level; X = irrelevant; ? = indeterminate; Z = high impedance$ 





**Figure 25. Equivalent Input and Output Schematic Diagrams**



#### <span id="page-20-0"></span>**9 Application and Implementation**

#### **NOTE**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### <span id="page-20-1"></span>**9.1 Application Information**

The CAN bus has two states during powered operation of the device; dominant and recessive. A dominant bus state is when the bus is driven differentially, corresponding to a logic low on the D and R pin. A recessive bus state is when the bus is biased to  $V_{C}Q^2$  via the high-resistance internal resistors  $R_{\text{IN}}$  and  $R_{\text{ID}}$  of the receiver, corresponding to a logic high on the D and R pins. See [Figure](#page-20-2) 26 and [Figure](#page-20-3) 27.



**Figure 27. Simplified Recessive Common Mode Bias and Receiver**

<span id="page-20-3"></span><span id="page-20-2"></span>The HVD251 CAN transceiver is typically used in applications with a host microprocessor or FPGA that includes the link layer portion of the CAN protocol. The different nodes on the network are typically connected through the use of a 120-Ω characteristic impedance twisted pair cable with termination on both ends of the bus.

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#### **Application Information (continued)**

The basics of bus arbitration require that the receiver at the sending node designate the first bit as dominant or recessive after the initial wave of the first bit of a message travels to the most remote node on a network and back again. Typically, this *sample* is made at 75% of the bit width, and within this limitation, the maximum allowable signal distortion in a CAN network is determined by network electrical parameters.

Factors to be considered in network design include the 5 ns/m propagation delay of typical twisted-pair bus cable; signal amplitude loss due to the loss mechanisms of the cable; and the number, length, and spacing of drop-lines (stubs) on a network. Under strict analysis, variations among the different oscillators in a system must also be accounted for with adjustments in signaling rate and stub and bus length. [Table](#page-21-0) 4 lists the maximum signaling rates achieved with the HVD251 in high-speed mode with several bus lengths of category-5, shielded twisted-pair (CAT 5 STP) cable.



#### **Table 4. Maximum Signaling Rates for Various Cable Lengths**

<span id="page-21-0"></span>The ISO 11898 standard specifies a maximum bus length of 40 meters and maximum stub length of 0.3 meters with a maximum of 30 nodes. However, with careful design, users can have longer cables, longer stub lengths, and many more nodes on a bus. (Note: Non-standard application may come with a trade-off in signaling rate.) A bus with a large number of nodes requires a transceiver with high input impedance such as the HVD251.

The Standard specifies the interconnect to be a single twisted-pair cable (shielded or unshielded) with 120-Ω characteristic impedance (Zo). Resistors equal to the characteristic impedance of the line terminate both ends of the cable to prevent signal reflections. Unterminated drop-lines connect nodes to the bus and should be kept as short as possible to minimize signal reflections.

Connectors, while not specified by the ISO 11898 standard, should have as little effect as possible on standard operating parameters such as capacitive loading. Although unshielded cable is used in many applications, data transmission circuits employing CAN transceivers are usually used in applications requiring a rugged interconnection with a wide common-mode voltage range. Therefore, shielded cable is recommended in these electronically harsh environments, and when coupled with the –2-V to 7-V common-mode range of tolerable ground noise specified in the standard, helps to ensure data integrity. The HVD251 extends data integrity beyond that of the standard with an extended –7-V to 12-V range of common-mode operation.



**Figure 28. Typical CAN Differential Signal Eye-Pattern**

<span id="page-22-0"></span>An eye pattern is a useful tool for measuring overall signal quality. As displayed in [Figure](#page-22-0) 28, the differential signal changes logic states in two places on the display, producing an *eye*. Instead of viewing only one logic crossing on the scope, an entire *bit* of data is brought into view. The resulting eye pattern includes all effects of systemic and random distortion, and displays the time during which a signal may be considered valid.

The height of the eye above or below the receiver threshold voltage level at the sampling point is the noise margin of the system. Jitter is typically measured at the differential voltage zero-crossing during the logic state transition of a signal. Note that jitter present at the receiver threshold voltage level is considered by some to be a more effective representation of the jitter at the input of a receiver.

As the sum of skew and noise increases, the eye closes and data is corrupted. Closing the width decreases the time available for accurate sampling, and lowering the height enters the 900-mV or 500-mV threshold of a receiver.

Different sources induce noise onto a signal. The more obvious noise sources are the components of a transmission circuit themselves; the signal transmitter, traces & cables, connectors, and the receiver. Beyond that, there is a termination dependency, cross-talk from clock traces and other proximity effects,  $V_{CC}$  and ground bounce, and electromagnetic interference from near-by electrical equipment.

The balanced receiver inputs of the HVD251 mitigate most sources of signal corruption, and when used with a quality shielded twisted-pair cable, help meet data integrity.

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**ISTRUMENTS** 

EXAS

#### **9.2 Typical Application**

<span id="page-23-0"></span>

**Figure 29. Typical Application Schematic**

#### **9.2.1 Design Requirements**

#### *9.2.1.1 Bus Loading, Length, and Number of Nodes*

The ISO11898 Standard specifies up to 1-Mbps data rate, maximum bus length of 40 meters, maximum drop line (stub) length of 0.3 meters and a maximum of 30 nodes. However, with careful network design, the system may have longer cables, longer stub lengths, and many more nodes to a bus. Many CAN organizations and standards have scaled the use of CAN for applications outside the original ISO11898 standard. They have made system level trade-offs for data rate, cable length, and parasitic loading of the bus. Examples of some of these specifications are ARINC825, CANopen, CAN Kingdom, DeviceNet and NMEA200.



**Figure 30. Typical CAN Bus**



#### **Typical Application (continued)**

A high number of nodes requires a transceiver with high input impedance and wide common mode range such as the SNx5HVD251 CAN transceiver. ISO11898-2 specifies the driver differential output with a 60-Ω load (two 120-Ω termination resistors in parallel) and the differential output must be greater than 1.5 V. The SNx5HVD251 devices are specified to meet the 1.5-V requirement with a 60-Ω load, and additionally specified with a differential output voltage minimum of 1.2 V across a common mode range of –2 V to 7 V via a 330-Ω coupling network. This network represents the bus loading of 120 SNx5HVD251 transceivers based on their minimum differential input resistance of 40 kΩ. Therefore, the SNx5HVD251 supports up to 120 transceivers on a single bus segment with margin to the 1.2-V minimum differential input voltage requirement at each node.

For CAN network design, margin must be given for signal loss across the system and cabling, parasitic loadings, network imbalances, ground offsets and signal integrity thus a practical maximum number of nodes may be lower. Bus length may also be extended beyond the original ISO 11898 standard of 40 meters by careful system design and data rate tradeoffs. For example, CANopen network design guidelines allow the network to be up to 1 km with changes in the termination resistance, cabling, less than 64 nodes and significantly lowered data rate.

This flexibility in CAN network design is one of the key strengths of the various extensions and additional standards that have been built on the original ISO 11898 CAN standard.

#### **9.2.2 Detailed Design Procedure**

#### *9.2.2.1 CAN Termination*

The ISO 11898 standard specifies the interconnect to be a twisted pair cable (shielded or unshielded) with 120-Ω characteristic impedance  $(Z<sub>O</sub>)$ . Resistors equal to the characteristic impedance of the line should be used to terminate both ends of the cable to prevent signal reflections. Unterminated drop lines (stubs) connecting nodes to the bus should be kept as short as possible to minimize signal reflections. The termination may be on the cable or in a node, but if nodes may be removed from the bus the termination must be carefully placed so that it is not removed from the bus.

Termination is typically a 120-Ω resistor at each end of the bus. If filtering and stabilization of the common mode voltage of the bus is desired, then split termination may be used (see Figure 30). Split termination utilizes two 60-  $\Omega$  resistors with a capacitor in the middle of these resistors to ground. Split termination improves the electromagnetic emissions behavior of the network by eliminating fluctuations in the bus common mode voltages at the start and end of message transmissions.

Care should be taken when determining the power ratings of the termination resistors. A typical worst case fault condition is if the system power supply and ground were shorted across the termination resistance which would result in much higher current through the termination resistance than the CAN transceiver's current limit.

<span id="page-24-0"></span>





#### **Typical Application (continued)**

#### *9.2.2.2 Loop Propagation Delay*

Transceiver loop delay is a measure of the overall device propagation delay, consisting of the delay from the driver input (D pin) to the differential outputs (CANH and CANL pins), plus the delay from the receiver inputs (CANH and CANL) to its output pin.

A typical loop delay for the SNx5HVD251 transceiver is displayed in [Figure](#page-25-1) 32. This loop delay will increase as the slope of the driver output is slowed during slope control mode. This increased loop delay means that there is a tradeoff between the total bus length able to be used and the driver's output slope used via the slope control pin of the device. For example, the loop delay for a 10-kΩ resistor from the R<sub>S</sub> pin to ground is ~100 ns, and the loop delay for a 100-kΩ resistor is ~500 ns. Therefore, if we use the following rule-of-thumb that the propagation delay of typical twisted pair bus cable is 5 ns/m, we can calculate an approximate cable length trade-off between normal high-speed mode and slope control mode with a 100-kΩ resistor. Using typical values, the loop delay for a recessive to dominant bit with R<sub>S</sub> tied directly to ground is 60ns, and with a 100-kΩ resistor is 440 ns. At 5ns/m of propagation delay, which you have to count in both directions the difference is 38 meters  $(440 - 60)/(2 \times$ 5).

Another option to improving the electromagnetic emissions of the device besides slowing down the edge rates of the driver in slope control mode is using quality shielded bus cabling.

## Trig'd  $\frac{1}{2}$  1.00 V  $40.0ns$  $5.00$ GS/s  $3.56V$  $2.00V$ A. Min Max<br>-301.1n 99.85n Value<br>99.76ns  $\frac{Mean}{41.57n}$ **Std Dev**<br>57.84n 100k points D15-D0<br>MF Timing Resolution: 2.00ns  $\begin{bmatrix} 2 & Feb & 2015 \\ 13:52:09 \end{bmatrix}$

#### **9.2.3 Application Curve**

**Figure 32. t**<sub>LOOP</sub> Delay

#### <span id="page-25-1"></span><span id="page-25-0"></span>**9.3 System Example**

#### **9.3.1 ISO 11898 Compliance of HVD251 5-V CAN Bus Transceiver**

#### *9.3.1.1 Introduction*

The SNx5HVD251 CAN transceiver is a 5-V CAN transceiver that meets or exceeds the specification of the ISO 11898 standard for applications employing a controller area network.

#### *9.3.1.2 Differential Signal*

CAN is a differential bus where complementary signals are sent over two wires and the voltage difference between the two wires defines the logical state of the bus. The differential CAN receiver monitors this voltage difference and outputs the bus state with a single ended logic level output signal.



#### **System Example (continued)**



**Figure 33. Differential Output Waveform**

<span id="page-26-0"></span>The CAN driver creates the differential voltage between CANH and CANL in the dominant state. The dominant differential output of the HVD251 is greater than 1.5 V and less than 3 V across a 60-Ω load as defined by the ISO 11898 standard. [Figure](#page-26-0) 33 shows CANH, CANL, and the differential dominant state level for the SNx5HVD251.

A CAN receiver is required to output a recessive state when less than 500 mV of differential voltage exists on the bus, and a dominant state when more than 900 mV of differential voltage exists on the bus. The CAN receiver must do this with common-mode input voltages from –2 V to 7 V.

#### *9.3.1.3 Common-Mode Signal*

A common-mode signal is an average voltage of the two signal wires that the differential receiver rejects. The common-mode signal comes from the CAN driver, ground noise, and coupled bus noise. Since the bias voltage of the recessive state of the device is dependent on  $V_{CC}$ , any noise present or variation of  $V_{CC}$  will have an effect on this bias voltage seen by the bus. The HVD251 CAN transceiver has the recessive bias voltage set to 0.5 x  $V_{CC}$  to comply with the ISO 11898-2 CAN standard.



#### <span id="page-27-0"></span>**10 Power Supply Recommendations**

To ensure reliable operation at all data rates and supply voltages, each supply should be decoupled with a 100 nF ceramic capacitor located as close as possible to the  $V_{CC}$  supply pins as possible. The TPS76350 is a linear voltage regulator suitable for the 5-V supply rail.

### <span id="page-27-1"></span>**11 Layout**

#### <span id="page-27-2"></span>**11.1 Layout Guidelines**

In order for the PCB design to be successful, start with design of the protection and filtering circuitry. Because ESD and EFT transients have a wide frequency bandwidth from approximately 3-MHz to 3-GHz, high frequency layout techniques must be applied during PCB design. On chip IEC ESD protection is good for laboratory and portable equipment but is usually not sufficient for EFT and surge transients occurring in industrial environments. Therefore robust and reliable bus node design requires the use of external transient protection devices at the bus connectors. Placement at the connector also prevents these harsh transient events from propagating further into the PCB and system.

Use  $V_{CC}$  and ground planes to provide low inductance.

**NOTE**

High frequency current follows the path of least inductance and not the path of least resistance.

Design the bus protection components in the direction of the signal path. Do not force the transient current to divert from the signal path to reach the protection device.

An example placement of the Transient Voltage Suppression (TVS) device indicated as D1 (either bi-directional diode or varistor solution) and bus filter capacitors C5 and C7 are shown in [Figure](#page-28-1) 34.

The bus transient protection and filtering components should be placed as close to the bus connector, J1, as possible. This prevents transients, ESD and noise from penetrating onto the board and disturbing other devices.

Bus termination: [Figure](#page-24-0) 31 shows split termination. This is where the termination is split into two resistors, R5 and R6, with the center or split tap of the termination connected to ground via capacitor C6. Split termination provides common mode filtering for the bus. When termination is placed on the board instead of directly on the bus, care must be taken to ensure the terminating node is not removed from the bus as this will cause signal integrity issues if the bus is not properly terminated on both ends.

Bypass and bulk capacitors should be placed as close as possible to the supply pins of transceiver, examples C2, C3  $(V_{CC})$ .

Use at least two vias for  $V_{CC}$  and ground connections of bypass capacitors and protection devices to minimize trace and via inductance.

To limit current of digital lines, serial resistors may be used. Examples are R1, R2, R3 and R4.

To filter noise on the digital IO lines, a capacitor may be used close to the input side of the IO as shown by C1 and C4.

Since the internal pull up and pull down biasing of the device is weak for floating pins, an external 1-kΩ to 10-kΩ pullup or pulldown resistor should be used to bias the state of the pin more strongly against noise during transient events.

Pin 1: If an open-drain host processor is used to drive the D pin of the device an external pullup resistor between 1 kΩ and 10 kΩ should be used to drive the recessive input state of the device.

Pin 5: is  $V_{REF}$  output voltage reference, if used, this pin should be tied to the common mode point of the split termination. If  $V_{REF}$  is not used, the pin can be left floating.

Pin 8: is shown assuming the mode pin,  $R_s$ , will be used. If the device will only be used in high-speed mode or slope control mode, R3 is not needed and the pads of C4 could be used for the pulldown resistor to GND.



## <span id="page-28-0"></span>**11.2 Layout Example**



<span id="page-28-1"></span>**Figure 34. Layout Example Recommendation**

#### <span id="page-29-1"></span>**12 Device and Documentation Support**

#### <span id="page-29-0"></span>**12.1 Related Links**

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.



#### **Table 5. Related Links**

#### <span id="page-29-2"></span>**12.2 Community Resources**

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms](http://www.ti.com/corp/docs/legal/termsofuse.shtml) of [Use.](http://www.ti.com/corp/docs/legal/termsofuse.shtml)

**TI E2E™ Online [Community](http://e2e.ti.com)** *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design [Support](http://support.ti.com/)** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### <span id="page-29-3"></span>**12.3 Trademarks**

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### <span id="page-29-4"></span>**12.4 Electrostatic Discharge Caution**



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### <span id="page-29-5"></span>**12.5 Glossary**

[SLYZ022](http://www.ti.com/lit/pdf/SLYZ022) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

#### <span id="page-29-6"></span>**13 Mechanical, Packaging, and Orderable Information**

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



### **PACKAGING INFORMATION**



**(1)** The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures. "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

**(3)** MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**(4)** There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

**(5)** Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



## **PACKAGE OPTION ADDENDUM**

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<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### **OTHER QUALIFIED VERSIONS OF SN65HVD251 :**

• Automotive : [SN65HVD251-Q1](http://focus.ti.com/docs/prod/folders/print/sn65hvd251-q1.html)

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## **PACKAGE MATERIALS INFORMATION**

Texas **NSTRUMENTS** 

www.ti.com 5-Jan-2022

### **TAPE AND REEL INFORMATION**





#### **QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**





Pack Materials-Page 1



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## **PACKAGE MATERIALS INFORMATION**



\*All dimensions are nominal



Pack Materials-Page 2



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### **TUBE**



#### \*All dimensions are nominal



 $P (R-PDIP-T8)$ 

PLASTIC DUAL-IN-LINE PACKAGE



- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 variation BA.



## **MECHANICAL DATA**



 $C.$ SON (Small Outline No-Lead) package configuration.

 $\overline{\bigtriangleup}$  The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.

E. Package complies to JEDEC MO-229 variation WGGB.



Downloaded From [Oneyac.com](https://www.oneyac.com)

#### DRJ (S-PWSON-N8) PLASTIC SMALL OUTLINE NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



#### NOTE: All linear dimensions are in millimeters





NOTES: All linear dimensions are in millimeters. А.

- This drawing is subject to change without notice. **B.**
- Publication IPC-7351 is recommended for alternate designs. C.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http://www.ti.com>.
- E. Laser cutting apertures with electropolish and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for solder mask tolerances and vias tenting recommendations for vias placed in the thermal pad.





## **PACKAGE OUTLINE**

## **D0008A SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



# **EXAMPLE BOARD LAYOUT**

## **D0008A SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# **EXAMPLE STENCIL DESIGN**

## **D0008A SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



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